


Search Notes 	Application/Control No. 10581959	Applicant(s)/Patent Under Reexamination YOON, IL SHIK
	Examiner Stefan Krueer	Art Unit 3654

SEARCHED			
Class	Subclass	Date	Examiner
187	314, 393, 401, 414,	03/17/2008	SHK
52	220.8, 717.01, 718.01, 506.01 - 506.09		
248	544, 237, 221.11, 301, 323, 343		
B66B	13/02, 11/02, 7/00		
454	68,292, 370		

SEARCH NOTES			
Search Notes		Date	Examiner
PLUS		03/17/2008	SHK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner